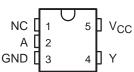
- EPIC<sup>™</sup> (Enhanced-Performance Implanted CMOS) Submicron Process
- Unbuffered Output
- Supports 5-V V<sub>CC</sub> Operation
- Package Options Include Plastic Small-Outline Transistor (DBV, DCK) Packages

### DBV OR DCK PACKAGE (TOP VIEW)



NC - No internal connection

### description

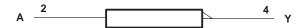
This single inverter gate is designed for 1.65-V to 5.5-V  $V_{CC}$  operation.

The SN74LVC1GU04 contains one inverter with an unbuffered output, and performs the Boolean function  $Y = \overline{A}$ . The SN74LVC1GU04 is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.

#### **FUNCTION TABLE**

INPUT A	OUTPUT Y
Н	L
L	Н

### logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

#### logic diagram (positive logic)





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SCES215D - APRIL 1999 - REVISED JULY 2000

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Complex selfence age as M	0 5 1/4- 0 5 1/
Supply voltage range, V <sub>CC</sub>	
Input voltage range, V <sub>I</sub> (see Note 1)	
Output voltage range, VO (see Notes 1 and 2)	0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–50 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	–50 mA
Continuous output current, IO	±50 mA
Continuous current through V <sub>CC</sub> or GND	±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3): DBV package	206°C/W
DCK package	252°C/W
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
  - 2. The value of V<sub>CC</sub> is provided in the recommended operating conditions table.
  - 3. The package thermal impedance is calculated in accordance with JESD 51.

### recommended operating conditions

			MIN	MAX	UNIT
VCC	Supply voltage		1.65	5.5	V
٧ <sub>IH</sub>	High-level input voltage	I <sub>O</sub> = -100 μA	0.75 × V <sub>CC</sub>		V
$V_{IL}$	Low-level input voltage	I <sub>O</sub> = 100 μA		$0.25 \times V_{CC}$	V
٧ <sub>I</sub>	Input voltage		0	5.5	V
٧o	Output voltage		0	VCC	V
		V <sub>CC</sub> = 1.65 V		-4	
		V <sub>CC</sub> = 2.3 V		-8	mA
IOH		V <sub>CC</sub> = 3 V		-16	
		VCC = 3 V		-24	
		V <sub>CC</sub> = 4.5 V		-32	
		V <sub>CC</sub> = 1.65 V		4	
		V <sub>CC</sub> = 2.3 V		8	
$I_{OL}$	Low-level output current	V <sub>CC</sub> = 3 V		16	mA
		ACC = 2 A		24	
	V <sub>CC</sub> = 4.5 V			32	
TA	Operating free-air temperature		-40	85	°C



# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		VCC	MIN	TYP <sup>†</sup>	MAX	UNIT
		I <sub>OH</sub> = -100 μA	1.65 V to 5.5 V	V <sub>CC</sub> -0.1			
		I <sub>OH</sub> = -4 mA	1.65 V	1.2			
V	V <sub>II</sub> = 0 V	I <sub>OH</sub> = -8 mA	2.3 V	1.9			V
VOH	VIL = 0 V	I <sub>OH</sub> = -16 mA	0.1/	2.4			
		I <sub>OH</sub> = -24 mA	3 V	2.3			
		I <sub>OH</sub> = -32 mA	4.5 V	3.8			
	VIH= VCC	I <sub>OL</sub> = 100 μA	1.65 V to 5.5 V			0.1	
		I <sub>OL</sub> = 4 mA	1.65 V			0.45	
\/		I <sub>OL</sub> = 8 mA	2.3 V			0.3	V
VOL		I <sub>OL</sub> = 16 mA	2.1/			0.4	v
		I <sub>OL</sub> = 24 mA	3 V			0.55	
		I <sub>OL</sub> = 32 mA	4.5 V			0.55	
Ι <sub>Ι</sub>	V <sub>I</sub> = 5.5 V or GND		0 to 5.5 V			±5	μΑ
lcc	V <sub>I</sub> = 5.5 V or GND,	IO = 0	1.65 V to 5.5 V			10	μА
Ci	V <sub>I</sub> = V <sub>CC</sub> or GND		3.3 V		7		pF

 $<sup>\</sup>dagger$  All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.

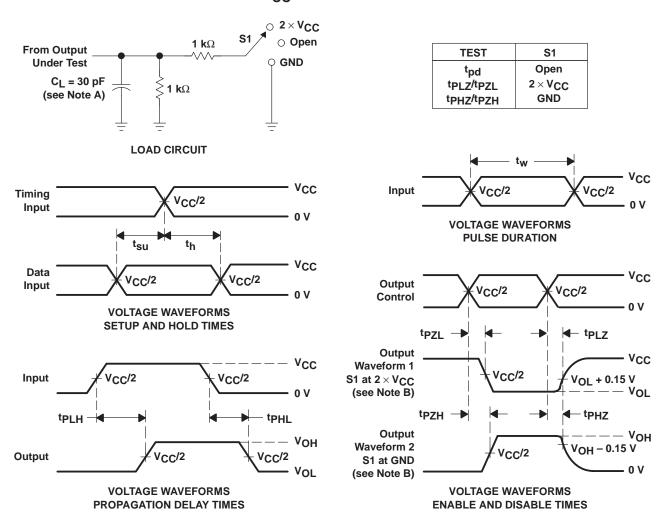
# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 4)

PARAMETER	FROM (INPUT)	TO (OUTPUT)		V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 1.8 V ± 0.15 V V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		V <sub>CC</sub> = 5 V ± 0.5 V		UNIT
	(1141 01)	(0011 01)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
<sup>t</sup> pd	A	Y	1.3	5	1	4	1.1	3.7	1	3	ns	

### operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS		V <sub>CC</sub> = 3.3 V	UNIT		
	PARAMETER			TYP	TYP	UNIT	
C <sub>pd</sub>	Power dissipation capacitance	f = 10 MHz	9	11	13	27	pF

## PARAMETER MEASUREMENT INFORMATION $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$



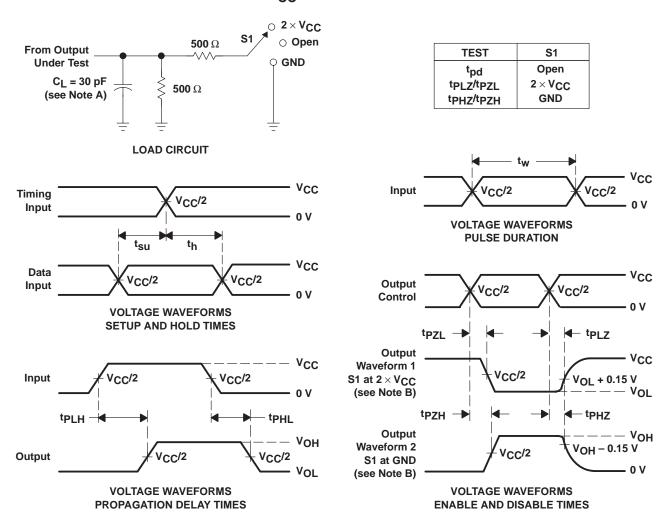
NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq 2$  ns.  $t_f \leq 2$  ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



### PARAMETER MEASUREMENT INFORMATION $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$

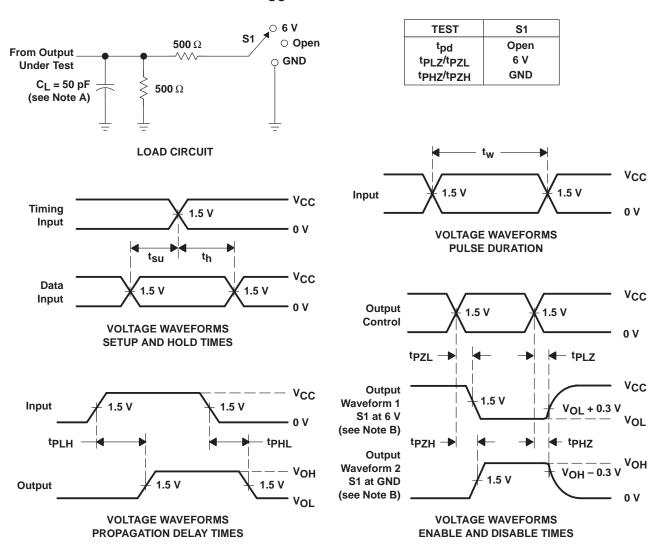


NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O$  = 50  $\Omega_{\rm i}$   $t_f$   $\leq$  2 ns.  $t_f$   $\leq$  2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms

## PARAMETER MEASUREMENT INFORMATION $V_{CC}$ = 3.3 V $\pm$ 0.3 V



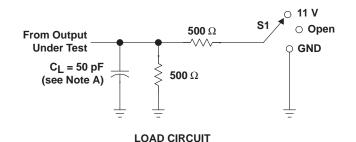
NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_Q = 50 \,\Omega$ ,  $t_f \leq 2.5 \,\text{ns}$ ,  $t_f \leq 2.5 \,\text{ns}$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

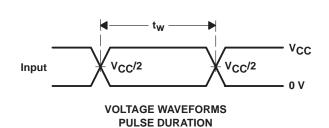
Figure 3. Load Circuit and Voltage Waveforms

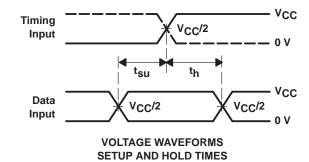


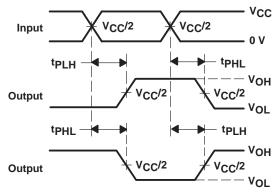
## PARAMETER MEASUREMENT INFORMATION $V_{CC}$ = 5 V $\pm$ 0.5 V

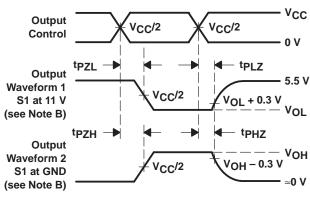


TEST	S1
tPLH/tPHL	Open
tPLZ/tPZL	11 V
tPHZ/tPZH	GND









VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
INVERTING AND NONINVERTING OUTPUTS

VOLTAGE WAVEFORMS ENABLE AND DISABLE TIMES LOW- AND HIGH-LEVEL ENABLING

NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_{O} = 50 \Omega$ ,  $t_{f} \leq$  2.5 ns,  $t_{f} \leq$  2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. tpZL and tpZH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 4. Load Circuit and Voltage Waveforms

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